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1. Introduction

Magnetoelectric composite ceramics, which combine both dielectric and magnetic properties, have gained significant attention for their potential use in multifunctional devices such as miniaturized filters, antennas, and electromagnetic interference shielding.¹⁻³ These materials rely on magnetoelectric coupling and offer immense promise for advanced technological applications. Notable examples include the BaTiO₃–(MnZn)Fe₂O₄, BaTiO₃–YFeO₃ system, which demonstrates high capacitance and static permeability and Ba_{0.8}Sr_{0.2}TiO₃/YFeO₃ composites that exhibit exceptional permittivity and high saturation magnetization.⁴⁻⁶ However, traditional solid-state methods used to synthesize these materials often require elevated sintering temperatures, which can lead to undesirable diffusion between the dielectric and magnetic phases, resulting in performance degradation and increased grain size.⁴

YFeO₃ exists in two distinct polymorphic forms: an orthorhombic perovskite-type structure and a hexagonal structure.

E-mail: rkparida65@gmail.com, bnparida@cit.ac.in

^b Department of Physics, Siksha 'O' Anusandhan (Deemed to be University), Khandigiri, Bhubaneswar, Odisha 751030, India



Harshavardhan Chouhan,^a Saurabh Prasad,^a B. N. Parida^a and R. K. Parida^b*^b

The solid-state reaction method was successfully employed to synthesize the environmentally friendly polycrystalline perovskite ($Y_{0.5}Ni_{0.5}FeO_3$)_{0.5}(BaTiO₃)_{0.5}. X-ray diffraction (XRD) analysis, complemented by Rietveld refinement, confirms its multiphase crystalline structure, comprising two cubic and one orthorhombic phase. Field-emission scanning electron microscopy (FE-SEM) reveals a well-defined surface morphology, while energy-dispersive spectroscopy (EDS) and elemental mapping validate the homogeneous distribution of constituent elements. Raman and FTIR spectroscopy further confirm the vibrational and atomic structural integrity of the material. Dielectric studies indicate a high dielectric constant (\sim 338 at 100 Hz, room temperature), with strong frequency and temperature-dependent relaxation effects. Impedance spectroscopy reveals non-Debye relaxation behaviour, NTCR characteristics and impedance in the megaohm range at lower temperatures. AC conductivity results align well with Jonscher's power law. The thermistor coefficient (β) reaches 4778.61 at 450 °C, demonstrating excellent potential for thermistor applications. Magnetic studies confirm a prominent ferromagnetic response at room temperature, with a saturation magnetization of 3.654 emu g⁻¹ and coercive field of 196.4 Oe. These combined properties make ($Y_{0.5}Ni_{0.5}FeO_3$)_{0.5}(BaTiO₃)_{0.5} a promising candidate for multifunctional applications.

The orthorhombic phase, which crystallizes in the *Pnma* space group, is the more stable and widely studied form, exhibiting Gtype antiferromagnetism. Its magnetic properties are derived from Fe³⁺ ions at the octahedral sites, surrounded by six neighbouring magnetic ions arranged in FeO₆ octahedra. The weak ferromagnetism observed in YFeO3 is the result of a canted antiferromagnetic ordering, driven by superexchange interactions between Fe3+-O-Fe2+ bonds and the Dzyaloshinskii-Moriya (DM) interaction. YFeO₃has a high Néel temperature (370 °C) and a low Curie temperature (-256 °C), further emphasizing its potential as a robust material for roomtemperature applications.^{7,8} Orthorhombic YFeO₃ in addition to its magnetic properties, displays interesting dielectric and electrical properties, including ferroelectricity, which is mainly attributed to structural distortions within the perovskite framework. The presence of Fe³⁺ ions contributes to charge transfer between Fe²⁺ and Fe³⁺ states, which in turn induces dielectric polarization via the Wagner space charge effect. The dielectric relaxation behaviour observed in YFeO3 is due to the movement of charge carriers between these iron states. As a result, YFeO₃ is of interest for potential applications in memory storage, sensors and other electronic devices.^{9,10} The hexagonal phase of YFeO3, while offering superior photocatalytic properties and a smaller optical bandgap (~ 1.96 eV), is much more

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^a Department of Physics, Central Institute of Technology Kokrajhar (Deemed to be University, MOE, Govt. of India), BTR, Assam 783370, India.

challenging to synthesize and stabilize.¹¹ The transformation from the hexagonal to the orthorhombic phase typically occurs at higher calcination temperatures, limiting the feasibility of obtaining a pure hexagonal phase. Previous research suggests that the hexagonal phase can only be achieved within a very narrow temperature range (700-720 °C) using the sol-gel method, with coexisting minor phases such as Y₂O₃ or Fe₂O₃, further complicating its synthesis.^{11–13} YFeO₃, like other rareearth orthoferrites (RFeO₃), has been the focus of extensive research due to its potential applications in magneto-optical devices, including optical switches, magnetic field sensors and current sensors. The magneto-electric coupling in YFeO₃, although weak, is significant enough to offer utility in these applications. Recent advances in materials science have led to the development of methods for improving the multiferroic properties of YFeO₃ through ion substitution or doping. By substituting elements into the A-site (Y^{3+}) or B-site (Fe^{3+}) of the perovskite structure, it is possible to tune and enhance the material's dielectric, magnetic, and ferroelectric properties.14,15

Several studies have reported on the effects of different dopants on the properties of YFeO₃. For instance, doping with Ca²⁺ in place of Y³⁺ has been shown to enhance electrical conductivity by creating hole localization on the Fe site to compensate for the charge difference between Ca²⁺ and Y³⁺.¹⁶ Similarly, doping with magnetic ions such as Gd³⁺ has been found to enhance magnetic behaviour due to additional Gd-Fe interactions and structural distortions. Other dopants, such as Zn, Cd, Cr, and Lu, have also been investigated, yielding modifications in both magnetic and dielectric properties.¹⁷⁻¹⁹ A critical aspect of enhancing the multiferroic properties of YFeO₃ involves careful control over the doping concentration. For example, the introduction of Er³⁺ at low concentrations improves magnetic properties, but at higher concentrations, the material shifts from weak ferromagnetism to paramagnetic behaviour.²⁰ On the other hand, B-site doping of Fe³⁺ with elements like Mn3+ has been found to reduce relative permittivity and contribute to dielectric relaxation processes, which are influenced by oxygen vacancies within the material.²¹ Moreover, recent research has focused on the substitution of Nd³⁺ ions into the A-site of YFeO₃. This substitution has been found to enhance the dielectric properties of YFeO₃ ceramics, particularly at high frequencies. Substituting Nd³⁺ does not cause any structural transformation but does influence the overall polarization and electrical behaviour, suggesting potential applications in high-frequency devices. The introduction of rare-earth ions like Nd3+, with different ionic radii compared to Y³⁺, is an effective strategy for tuning the ferroelectric and ferromagnetic properties of YFeO3 without compromising its structural integrity.17

In addition to magnetic and dielectric properties, YFeO₃ exhibits ferroelectric behaviour, although weak. The weak polarization observed in YFeO₃ provides a gap in the research, offering opportunities for further study and improvement. The challenge remains to enhance the ferroelectric properties while maintaining the material's multiferroic nature. Given the complex interplay between its magnetic and electric orders,

YFeO₃ offers a fertile ground for exploring novel approaches to material design and functionality.^{17,22,23}

The integration of YFeO₃ with BaTiO₃ results in a material with enhanced multiferroic properties, combining strong magnetic and dielectric behaviour. Introducing Ni ions into the YFeO₃ lattice further improves these properties. For instance, in the nanostructured $YFe_{1-x}Ni_xO_3$ system (x = 0.1, 0.15, 0.2, 0.25), prepared via co-precipitation and annealed at 800 °C. Magnetic measurements showed that Ni doping significantly increased the material's magnetic properties compared to pure YFeO₃. As the Ni content increased from x = 0.1 to 0.25, the coercivity (H_c) decreased from 1332.6 Oe to 887.8 Oe, while the saturation magnetization (M_s) rose from 0.67 to 1.17 emu g^{-1.24} Furthermore, studies on the YMn_{0.4}Fe_{0.6-x}Ni_xO₃ system (x = 0, 0.05, 0.075, 0.1), synthesized using the sol-gel process, showed DC conductivity of all samples followed the same trend as grain size, displaying semiconductor behaviour. Similarly, AC conductivity aligned with DC results, indicating that the non-overlapping small polaron tunneling (NSPT) model governs conduction in this multiferroic system.²⁵ Impedance spectroscopy revealed the contributions of both grain and grain boundaries to the overall conduction process, further supported by Nyquist plots. Among the samples, YMn_{0.4}Fe_{0.525}Ni_{0.075} O₃ demonstrated the highest conductivity, indicating that Ni substitution effectively enhances both electrical and magnetic properties in YFeO3-based materials. This demonstrates the potential of Ni-doped YFeO₃ for enhanced magnetic performance.

BaTiO₃ (BTO) is a well-established perovskite material, known for its excellent dielectric, piezoelectric, ferroelectric, and electro-optic properties. It finds widespread use in electronic components such as multilayer ceramic capacitors due to its high dielectric constant and thermal stability. On the other hand, YFeO₃ (YFO) exhibits notable magnetic and dielectric behaviour, including weak ferroelectricity and G-type antiferromagnetism, primarily due to structural distortions and charge transfer within its orthorhombic perovskite framework. However, the inherent magnetoelectric coupling in pristine YFO remains limited, and efforts to enhance its multifunctional properties have become increasingly vital for applications in sensors, memory devices, and multifunctional electronics.

In this context, the substitution of Ni into the YFO lattice is a key innovation of our work. Ni doping enhances magnetic characteristics such as increasing saturation magnetization (M_s) and modifying coercivity (H_c). By integrating ($Y_{0.5}Ni_{0.5}FeO_3$)_{0.5} with (BaTiO₃)_{0.5}, we have designed a new multiferroic composite that uniquely combines the enhanced magnetic behaviour of Nisubstituted YFO with the high permittivity and ferroelectric features of BTO.

This specific 50–50 composite composition has not been previously reported in the literature and demonstrates a synergistic improvement in both dielectric and magnetic performance. Furthermore, the material's temperature-dependent dielectric behaviour, electrical conductivity, and impedance responses suggest suitability for advanced multifunctional applications, including NTC thermistors, energy storage devices, and magneto-electric sensors. We believe the structural tuning through Ni substitution

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and the strategic integration with BTO bring genuine novelty to this study and offer a promising pathway toward next-generation multifunctional ceramics.

2. Experimental section

2.1 Preparation of material

We synthesized the sample $(Y_{0.5}Ni_{0.5}FeO_3)_{0.5}$ (BaTiO₃)_{0.5} using the conventional solid-state route, employing high-purity BaCO₃, Fe₂O₃, Y₂O₃, TiO₂ and Ni₂O₃ powders in precise proportions. We carefully weighed these powders according to stoichiometric requirements and blended them thoroughly using an agate mortar and pestle at room temperature to ensure homogeneity. The mixture was ground in both dry and wet conditions for 2 hours each, achieving a uniform admixture. The resulting powder underwent calcination in a programmable furnace, where it was heated gradually to 1200 °C and held for 4 hours. Afterward, we rigorously ground the calcined powder to obtain a lump-free consistency. We then formed cylindrical pellets by pelletizing the calcined material with polyvinyl alcohol (PVA) as a temporary binder. Finally, these pellets were sintered at 1300 °C for 3 hours to densify the sample and eliminate impurities, producing the final specimen.

2.2 Characterization of the material

2.2.1 X-Ray diffraction (XRD)

Instrument specifications. Rigaku Ultima IV diffractometer with CuK α radiation (wavelength 1.5418 Å), 2θ range of 20° – 90° with a step size of 0.02° .

2.2.2 Field emission scanning electron microscopy (FE-SEM) Instrument specifications. Carl Zeiss Gemini 300 FE-SEM with a magnification scale of 200 nm.

2.2.3 Energy dispersive spectroscopy (EDS)

Instrument specifications. Advanced EDS system integrated with FE-SEM for elemental analysis and color mapping.

2.2.4 Micro Raman spectroscopy

Instrument Specifications. Horiba Jobin Yvon LabRam HR laser Micro Raman spectrometer for vibrational modes and functional group analysis in the range from 150 cm^{-1} to 800 cm^{-1} .

2.2.5 Fourier transform infrared (FTIR) spectroscopy

Instrument Specifications. PerkinElmer FRONTIER IR and SPECTRUM 100 models for vibrational characteristic analysis in the range from 400 cm⁻¹ to 4000 cm⁻¹.

2.2.6 Dielectric, modulus, and conductivity analyzer

Instrument specifications. PSM-1735 LCR meter (Newtons4th Ltd, UK) operating in the frequency range of 100 Hz to 10^6 Hz and temperature range of 25 °C to 500 °C.

2.2.7 *I–V* characterization (leakage current measurement)

Instrument specifications. Keithley electrometer with a temperature range of 50 $^{\circ}$ C to 450 $^{\circ}$ C and operating range of -100 to 100 Volts.

2.2.8 Magnetic measurements (M-H loop magnetometry)

Instrument specifications. Microsense ADE-EV9 vibrating sample magnetometer (VSM) with a magnetic field range of -2 T to +2 T, performed at room temperature.

3. Results and discussion

3.1 Crystal structure

A good understanding of a material's crystal structure is required to comprehend its complexity and phase transitions. X-ray elastic scattering is utilized to collect crucial crystal information such as defects, unit cell size, strain, chemical structure and so on. Fig. 1(a) (marked by red dots) shows the X-ray diffraction intensity pattern for the synthesized sample, with Bragg's angle ranging from 20° to 90° at room temperature. The existence of numerous sharp, narrow, well-defined, and clear diffraction peaks confirms the powdered sample's high crystallinity, signifying an ordered and well-structured arrangement of atoms inside the crystal lattice. The peaks seen in the XRD spectrum are different from those of the raw chemicals, indicating the formation of a new structural arrangement. The synthesized XRD pattern was compared to the reference structure from the Crystallography Open Database using the QualX2 software, revealing that the sample has cubic symmetry and belongs to the $Pm\bar{3}m$



Fig. 1 (a) Rietveld refined XRD pattern of the investigated sample. (b) Williamson-Hall plot of the investigated sample.

Rietveld refinement is an effective method for analyzing the structure of ceramic samples, allowing for accurate measurement of lattice parameter variations. The data shown in Fig. 1(a) were generated using the Full-Prof software, which systematically and sequentially refined various parameters during the process. These parameters consists of background correction, scale factors, peak shapes, cell parameters, instrument zero-point, FWHM parameters, and individual atomic thermal and occupancy properties. The red circles in Fig. 1(a) represents experimental data, while the black lines represents refined data. The green vertical lines on the graph highlight the locations where the allowed Bragg diffraction peaks occur. Below these, the lower lines illustrate the difference between the intensities predicted by the software, shown as solid blue lines and the actual measured intensities from the experiment. Using cod database code 210 0862 of space group ' $Pm\bar{3}m$ ', cod database code 200 3125 of space group Pnma and cod database code 2 300 616 of space group $Fd\bar{3}m$ obtained from Crystallography Open Database the refinement is employed. The initial refinement, which considered only a cubic phase with the space group ' $Pm\bar{3}m$ ', was insufficient to account for all the observed peaks. However, by incorporating both orthorhombic and cubic phases with the space groups 'Pnma' and 'Fd3m', the data fitting significantly improved, resulting in a lower value of χ^2 and a more accurate match to the experimental results. The analysis of the data indicates that the cubic phase with the space group Pm3m accounts for 76.94% of the total composition, while the orthorhombic phase with the space group Pnma makes up 9.03%, and the cubic phase with the space group $Fd\bar{3}m$ contributes 14.03%. Table 1 presents the refined atomic positions for each phase. The refinement results are further supported by the reliability factors, with $R_{\rm p}(\%)$ at 4.02, $R_{\rm wp}(\%)$ at 5.84, $R_{exp}(\%)$ at 5.1, and χ^2 at 1.312. The low value of χ^2 , along with the alignment of the other reliability parameters, confirms a strong fit with the experimental data. Table 2 displays the refined cell parameters.

A detailed analysis of the XRD patterns is conducted using the Williamson-Hall (W-H) plot method. This method is based on an empirical formula, referred to as the Williamson-Hall (W-H) equation, which links two important factors in crystallography: (FWHM) *i.e.* full width at half maxima, denoted by β , and the lattice strain, symbolized by ε . The equation is expressed as follows:

$$\beta\cos\theta = \frac{k\lambda}{D} + 4\epsilon\sin\theta \tag{1}$$

In this equation, several variables are involved: k, known as the shape factor, has a value of approximately 0.89; λ represents the wavelength, 1.54 Å for Cu (K_{α}) radiation; D signifies the average crystallite size; θ is the measured diffraction angle; β corresponds to the full width at half maxima (FWHM); and ε indicates the lattice strain.

The Williamson-Hall plot, shown in Fig. 1(b), depicts the connection between $4\sin\theta$ (x-axis) and $\beta\cos\theta$ (y-axis), with

	Phase1 (Pm.	3 <i>m</i>)		
	Atomic posi	Atomic position		
Atoms	x	У	z	
Ва	0.5	0.5	0.5	
Ti	0	0	0	
0	0.5	0	0	
Y	0.5	0.5	0.5	
Fe	0	0	0	
Ni	0	0	0	

	Phase2 (<i>Pnma</i>) Atomic position						
Atoms							
	x	У	z				
Y	0.07408	0.25	-0.01109				
Fe	0	0	$\begin{array}{c} 0.5 \\ 0.09939 \\ 0.73944 \\ -0.01109 \\ 0.5 \\ 0.5 \end{array}$				
O O Ba Ni Ti	$\begin{array}{c} 0.41927 \\ -0.23468 \\ 0.07408 \\ 0 \\ 0 \\ 0 \end{array}$	0.25					
		$-0.0399 \\ 0.25 \\ 0 \\ 0$					
					Phase 3 ($Fd\bar{3}n$	ı)	
					Atomic positio	on	
				Atoms	x	У	z
Fe	0.125	0.125	0.125				
Fe	0.5	0.5	0.5				
0	0.24908	0.24908	0.24908				

Table 2 Refined cell parameters, angles and reliability factors

Parameters		Phase 1 (<i>Pm</i> 3 <i>m</i>)	Phase 2 (<i>Pnma</i>)	Phase 3 (<i>Fd</i> 3 <i>m</i>)
Cell parameters	a (Å)	4.004530	5.583677	8.335494
	b (Å)	4.004530	7.600788	8.335494
	c (Å)	4.004530	5.281495	8.335494
Cell angle	α	90	90	90
	β	90	90	90
	γ	90	90	90
Reliability factors	$R_{\rm p}$ $R_{\rm wp}$ $R_{\rm exp}$ χ^2	4.02 5.84 5.1 1.312		

linear regression applied to analyze the data. By comparing this equation to the standard linear form y = mx + c, the strain values can be calculated. From the analysis, the crystallite size is calculated to be approximately 253.34 nm, while the slope of the graph gives a lattice strain value of 0.000225.

3.2Analysis of microstructure and composition

Fig. 2(a) showcases an FE-SEM image of the sample's surface, highlighting its polycrystalline structure with grains of diverse sizes and irregular shapes dispersed unevenly. The micrograph also reveals voids between the grains, which contribute to the hopping mechanism in the material. In Fig. 2(b), a grain size distribution is depicted, calculated using ImageJ software. A Gaussian fit was applied to the histogram data, revealing an average grain size of 225 nm.

The initial elemental analysis was conducted using energydispersive X-ray spectroscopy (EDS). Fig. 2(c) shows the weight percentages of the elements obtained from a specific crosssectional region of the FESEM micrograph. The EDS spectrum, also illustrated in Fig. 2(c), confirms the presence of the expected elements in the sample, including Ba, Fe, Y, Ni, Ti and O. The absence of any impurity peaks from foreign elements in the spectrum further indicates that the synthesized sample is of high purity. Moreover, Fig. 2(d) presents the color mapping for each of the identified elements within the sample. The absence of any clustering in the images indicates a uniform distribution of these elements across the entire sample.

3.3 Raman spectroscopy

The ambient temperature Raman spectroscopy results for $(Y_{0.5}Ni_{0.5}FeO_3)_{0.5}(BaTiO_3)_{0.5}$, as shown in Fig. 3(a), offer valuable insights through a non-destructive technique. From the observed spectra and based on existing literature, we identified seven distinct Raman modes. Specifically, we observed three T_{2g} modes of Ni₂FeO₄ at 200 cm⁻¹, 481 cm⁻¹, and 564 cm⁻¹, labelled as $T_{2g}(I)$, $T_{2g}(II)$, and $T_{2g}(III)$, respectively; an E_g mode at 325 cm⁻¹; an A_{1g} mode near 700 cm⁻¹; and a B_{3g} mode of YFeO₃ at 249 cm⁻¹ and one at 637 cm⁻¹. While cubic BaTiO₃ theoretically exhibits no Raman-active modes, the A_{1g} mode of Ni₂FeO₄, detected around 700 cm⁻¹, is attributed to the symmetrical stretching of metal–oxygen bonds.²⁶ The E_g mode observed at 325 cm⁻¹ corresponds to the symmetric bending of oxygen atoms in relation to cations positioned at tetrahedral sites.²⁷

Further examination reveals that the $T_{2g}(I)$ mode at 200 cm⁻¹ and $T_{2g}(\pi)$ mode at 481 cm⁻¹ represent the asymmetric bending and stretching of the metal-oxygen bonds at octahedral sites, while the $T_{2g}(m)$ mode at 564 cm⁻¹ is linked with the translational movement of the metal-oxygen bonds at tetrahedral sites.²⁷ The closely spaced Raman peaks at approximately 481 cm⁻¹ and 564 cm⁻¹ were resolved by deconvoluting the Raman spectra using a Gaussian fitting model, as shown in Fig. 3(b). As reported by Iliev et al.,²⁸ the B_{3g} mode at 249 cm⁻¹, linked to YFeO₃, is a result of Y and O₁ atomic motions confined along the y-axis by site symmetry. The peak at 249 cm^{-1} , also observed in YCrO₃, reflects the vibration of the yttrium cation.²⁹ Additionally, the prominent broad feature at 637 cm⁻¹ likely originates from a two-phonon process and is possibly due to crystal disorder.³⁰ The Raman spectra reveal that the synthesized sample does not display any Raman-active modes characteristic of the tetragonal phase of BaTiO₃. Additionally, based on the literature, it is well-established that the cubic phase of BaTiO₃ lacks Raman-active modes. Therefore, we conclude that the sample has undergone a subtle transition to the cubic phase, likely due to the incorporation of BaTiO₃ into Ni_{0.5}Y_{0.5}FeO₃. This conclusion is well supported by XRD analysis, which confirms the findings from Raman spectroscopy. Together, these results provide useful insights into the structural changes in the sample, enhancing our understanding of its unique properties.

3.4 FTIR spectroscopy

FTIR analysis is employed to verify the atomic fingerprint of the compound. As depicted in Fig. 4, several transmittance peaks



Fig. 2 (a) SEM image of the investigated sample. (b) Histogram mapping for the crystalline size of the investigated sample. (c) EDX spectrum of the investigated sample. (d) The elemental color mapping of the investigated sample, along with the corresponding color mappings of Ti, Ba, O, Y, Fe and Ni individually.



Fig. 3 (a) RAMAN spectra of the investigated sample. (b) Deconvolution of RAMAN spectra.

were detected within the wavenumber range of 400 cm⁻¹ to 4000 cm⁻¹. A total of eleven distinct peaks were identified at the following wavenumbers: 410 cm⁻¹, 435 cm⁻¹, 451 cm⁻¹, 578 cm⁻¹, 861 cm⁻¹, 1100 cm⁻¹, 1443 cm⁻¹, 1635 cm⁻¹, 2850 cm⁻¹, 2924 cm⁻¹, and 3424 cm⁻¹.

The band at 410 cm⁻¹ is attributed to Ni–O stretching vibrations, while the peak at 435 cm⁻¹ is related to Ti–O bending along the polar axis.^{31,32} Strong signals at around 451 cm⁻¹ and 578 cm⁻¹ are linked to Fe–O stretching modes within the orthoferrite structure.³³ Peaks at 861 cm⁻¹ and 1443 cm⁻¹ are assigned to bending in the COO⁻ group.³² The band at 1100 cm⁻¹ corresponds to C–O vibrations.³³ Peaks near 1635 cm⁻¹ and 3424 cm⁻¹ indicate OH stretching and deformation vibrations, while the signals at 2850 cm⁻¹ and 2924 cm⁻¹ are due to symmetric and asymmetric stretching of the –CH₂ group, respectively.^{32–34}



Fig. 4 FTIR spectra of the investigated sample

3.5 Dielectric studies

The dielectric properties of the synthesized sample were measured over a temperature range of 25–400 °C and a frequency range of 100 Hz to 1 MHz, revealing a frequency and temperature dependent behaviour characteristic. The inset in Fig. 5 shows that the dielectric constant reaches a value of approximately 338 at 100 Hz at room temperature, indicating a high dielectric response at low frequencies. The coexistence of BaTiO₃ and YFeO₃ strongly affects the material's dielectric properties. BaTiO₃ has a high dielectric constant, reaching about 2500 at 25 °C and 100 Hz due to its ferroelectric nature, while YFeO₃ has a much lower dielectric constant of around 150 under the same conditions. The measured dielectric constant of 338 at 25 °C and



Fig. 5 Frequency-dependent dielectric constant (ϵ_r) at different temperatures.

100 Hz indicates that BaTiO₃ significantly enhances the dielectric response, but Ni doped YFeO₃ lowers the overall value. The interaction between these two phases, possibly through interfacial effects, further influences the dielectric behaviour, resulting in a dielectric constant lower than pure BaTiO₃ but higher than pure YFeO₃.³⁵

This significant dielectric value can be attributed to multiple polarization mechanisms within the sample, including dipolar, interfacial and space charge polarization effects. The primary dipoles responsible for this response are linked to ionic displacements within the components. Specifically, polar Ti–O and Fe–O bonds contribute to dipolar polarization, while defects, grain boundaries, and interfaces between YNiFeO₃ and BaTiO₃ phases are likely to create localized charges that produce interfacial and space charge polarizations at lower frequencies.³⁶

As frequency increases, the dielectric constant decreases, ultimately converging around 156 at high frequencies. This reduction in dielectric response with frequency aligns with the theory proposed by Koop and can be explained by the Maxwell-Wagner model for heterogeneous dielectrics.^{37,38} In this model, the inhomogeneous two-layer structure consists of conducting grains separated by insulating grain boundaries, which act as barriers to the movement of charge carriers. At lower frequencies, the grain boundaries allow charge accumulation, contributing to a high dielectric constant due to space charge polarization. However, as frequency rises, the ability of slower polarization mechanisms, such as interfacial and space charge polarization, to align with the rapidly oscillating electric field diminishes, causing a drop in dielectric constant. In ferrite-based systems, the local hopping of Fe³⁺ and Fe²⁺ ions contributes to polarization at lower frequencies. As frequency increases, the $Fe^{3+} \leftrightarrow Fe^{2+}$ hopping process becomes too slow to follow the field's rapid variations, further reducing ε_r at higher frequencies.³⁹

With increasing temperature, the dielectric constant also rises notably, reaching a value of approximately 1615 at 100 Hz at 400 °C, as illustrated in Fig. 5. This temperature-induced increase in dielectric constant is primarily due to the activation of thermally sensitive polarization mechanisms. At higher temperatures, thermal energy enhances the mobility of charge carriers and dipoles, facilitating their alignment with the applied field and thus increasing the overall dielectric response. Ionic dipoles, in particular, become more responsive to the electric field as thermal energy overcomes energy barriers to their movement. The increased dielectric response is due to thermally activated space charge polarization, mainly at the boundaries and interfaces of the sample, where charges move more freely at higher temperatures. These effects are more noticeable at low frequencies, as slower polarization mechanisms, like space charge effects, have more time to react, leading to a higher dielectric constant at elevated temperatures.40,41

Across all measured temperatures, the dielectric constant exhibits a similar frequency dependent decrease, converging around 160 at higher frequencies. This consistent convergence behaviour suggests that, regardless of temperature, the highfrequency dielectric response is dominated by faster polarization mechanisms, which remain active as other, slower mechanisms are unable to follow the rapid oscillations of the field. The dielectric dispersion observed in this material reflects a typical dielectric relaxation behaviour found in perovskite-based samples, where the contribution of multiple polarization mechanisms varies with both frequency and temperature. These results highlight the potential of the synthesized sample for applications where stable dielectric properties across a range of frequencies and temperatures are required. The high dielectric constant at low frequencies, combined with a consistent decrease at higher frequencies, demonstrates the material's strong dielectric response and adaptability, making it suitable for advanced electronic devices and components where reliable dielectric behaviour is crucial.

3.6 Loss tangent $(\tan \delta)$

The variation of loss tan δ with frequency for the sample is shown in Fig. 6 over a frequency range of 100 Hz to 1 MHz, covering temperatures from 25 °C to 400 °C. At each temperature, the tan δ values display a clear dependence on both frequency and temperature. At lower frequencies, the tan δ values are relatively high, a characteristic often attributed to the prominent role of interfacial or space charge polarization, which cannot keep pace with high-frequency fields. However, as frequency increases, tan δ gradually decreases and eventually converges to a minimum value at high frequencies. This trend suggests that as the frequency surpasses the response time of slow polarization mechanisms, such as space charge effects and dipolar interactions, these mechanisms contribute less to energy loss, leaving faster polarization processes, such as electronic and ionic polarizations, to govern the dielectric response.⁴²

As the temperature increases, the overall $\tan \delta$ values also increase at each frequency, showing higher energy loss. This happens because more thermal energy allows charge carriers and dipoles to move more easily and align with the electric field. As a result, polarization mechanisms, especially ionic and



Fig. 6 Frequency-dependent dielectric loss $(\tan \delta)$ at different temperatures.

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The inset in Fig. 6 provides a detailed view of tan δ at room temperature and in the higher temperature range of 325 °C to 400 °C. At room temperature, tan δ follows a similar pattern of decreasing with frequency but maintains lower values overall compared to higher temperatures. This indicates that at room temperature, fewer charge carriers and dipoles can align with the applied field, leading to lower dielectric losses. Conversely, in the 325–400 °C range, tan δ values are significantly elevated across all frequencies due to increased thermal activation of polarization mechanisms, particularly space charge and interfacial polarizations, which contribute prominently to the observed dielectric losses.⁴³

3.7 Impedance study

An analysis of impedance $Z^*(\omega)$ was conducted using general equations over a frequency range of 100 Hz to 1 MHz and a temperature range spanning 200 °C to 400 °C.

$$Z^{*}(\omega) = Z'(\omega) + jZ''(\omega)$$
$$Z'(\omega) = \frac{R}{\left\{1 + (\omega\tau)^{2}\right\}}$$
(2)

$$Z''(\omega) = \frac{-\omega R^2 C}{\left\{1 + (\omega \tau)^2\right\}}$$
(3)

3.7.1 Real Z. In Fig. 7(a), the relationship between real impedance (Z') and frequency across a wide temperature range of 200 °C to 400 °C reveals important insights into the dielectric and conductive behaviour of the material. The data illustrate a distinct decrease in Z' as frequency increases, a trend that appears consistently across all temperatures shown in the figure. This behaviour is characteristic of dielectric materials, where, at lower frequencies, the polarization within the material can more easily follow the applied external field, resulting in higher impedance values. However, as frequency increases, the ability of charge carriers to align with the oscillating field diminishes, leading to reduced polarization and lower impedance. This pattern holds at each temperature increment, where Z' converges toward a near-constant, minimum value at high frequencies. This convergence implies that, at elevated frequencies, the material's dielectric polarization contributions are limited, allowing the intrinsic resistive behaviour of the material to dominate.44

The effect of temperature on impedance is equally significant, with real impedance values exhibiting a marked decrease as temperature rises, characteristic of negative temperature coefficient of resistance (NTCR) behavior.⁴⁵ At 200 °C, the impedance lies within the mega-Ohm (M Ω) range, indicating limited charge carrier mobility as the thermal energy available



Fig. 7 (a) Variation of Z' with frequency at different temperatures. (b) Variation of Z'' with frequency at different temperatures. (c) Variation of Z'' with Z' (Nyquist plot) at selected temperatures. (d) Variation of Z'' with Z' (Nyquist plot) at selected temperatures.

is insufficient to overcome the potential barriers or traps restricting the movement of ions or electrons within the material. This high impedance at lower temperatures suggests that the material's structure may contain energy barriers or localized sites that inhibit charge mobility when thermal activation is low. However, as temperature increases, the material absorbs more thermal energy, which facilitates the activation of additional charge carriers and enhances their mobility, allowing them to overcome these barriers more readily. This thermally driven activation is reflected in the considerable reduction in impedance, with values dropping into the kilo-Ohm (k Ω) range by 400 °C, signaling a substantial increase in conductivity as temperature-driven conduction pathways become prominent within the material.

In the high-temperature region highlighted by the inset in Fig. 7(a), which spans 300–400 $^{\circ}$ C, we see that impedance values converge even more rapidly to a minimum level at elevated frequencies. This behaviour indicates that at these higher temperatures, the resistive properties of the material become dominant over the frequency-dependent dielectric effects. As the temperature rises, the impedance response increasingly resembles that of a pure conductor, where resistive behaviour prevails and becomes largely frequency-independent at high frequencies. This shift in behaviour suggests a fundamental change in the material's internal conduction mechanisms, where it transitions from a regime with limited mobility to one of enhanced carrier movement driven by thermal activation.⁴⁶

The NTCR effect observed here, where impedance decreases as temperature rises, is indicative of thermally activated conduction, a process where thermal energy assists charge carriers in overcoming energy barriers or hopping between localized states. This transition from high to low impedance over a wide temperature range points to an increased density and mobility of charge carriers within the material, possibly due to ion hopping or defect-mediated electron migration across the lattice. Such mechanisms are consistent with the properties of semiconducting materials, where resistance decreases with temperature, making the material suitable for applications as an NTC thermistor in high-temperature environments⁴⁷.

3.7.2 Imaginary Z. In Fig. 7(b), the behaviour of the imaginary component of impedance (Z') as a function of frequency across the temperature range of 200 °C to 400 °C reveals important details about the dielectric relaxation and energy dissipation characteristics of the material. The imaginary impedance, Z'' is often associated with the resistive loss or energy dissipation within the material as the charge carriers attempt to follow the alternating electric field. At 200 °C, the data show a pronounced relaxation peak at lower frequencies, which corresponds to a high degree of polarization, where the material's dipoles or charge carriers can effectively align with the slower oscillations of the applied field. This peak signifies a strong energy dissipation at low frequencies, indicating that the material's response is dominated by dielectric relaxation mechanisms, where the alignment and subsequent lag of the dipoles behind the applied field lead to a significant buildup of Z''. As the temperature increases, the relaxation peak in Z''

shifts toward higher frequencies, and the height of the peak decreases noticeably. This trend suggests that, at higher temperatures, the relaxation processes within the material become more efficient and require less time to follow the oscillating field. The shift of the relaxation peak to higher frequencies implies a reduction in the relaxation time, meaning the dipoles or charge carriers can realign with the applied electric field more rapidly as thermal energy enhances their mobility. This behaviour is characteristic of thermally activated conduction and relaxation mechanisms, where higher temperatures reduce the energy barriers or the viscosity of the medium, allowing the charge carriers to reorient with increasing ease. Consequently, the system's relaxation dynamics become faster, enabling the material to respond to higher-frequency fields with less energy dissipation, as reflected in the lower peak height of Z^{''}.⁴⁸

The reduction in the height of the relaxation peak with increasing temperature further suggests a decrease in dielectric losses at high temperatures. At elevated temperatures, the charge carriers gain sufficient thermal energy to move more freely, reducing the lag behind the field and diminishing the extent of energy dissipation in the form of resistive losses. This behaviour indicates a shift in the internal dynamics of the material, where thermally activated mechanisms reduce the magnitude of Z'' due to decreased polarization lag. By the time the temperature reaches 400 °C, the imaginary impedance peak has not only shifted significantly to a higher frequency but also decreased in height, indicating that the dielectric relaxation is happening at a much faster rate with minimal energy loss. The overall lower Z'' values at high temperatures further confirm that the material's response is more dominated by conduction rather than polarization lag, reflecting a transition toward a less dissipative state as the material's resistive pathways become increasingly prominent.49

The inset figure, which shows the imaginary impedance behaviour from 300 °C to 400 °C, provides a clearer view of the high-temperature range, where relaxation peaks continue to shift to higher frequencies and further decrease in height. This shift demonstrates the increasing dominance of conduction mechanisms over dielectric relaxation at elevated temperatures, with the frequency-dependent response becoming less prominent as temperature rises. In this high-temperature region, the imaginary impedance curve flattens out at high frequencies, indicating that, at these temperatures, the energy dissipation due to polarization lag is minimal and conduction pathways are well-established within the material. The material thus exhibits a behaviour where the relaxation time has become sufficiently short to respond efficiently to the higher frequency fields, which implies that any further increase in temperature will lead to even faster relaxation dynamics and potentially bring Z''closer to a frequency-independent behaviour.

The observed frequency shift and reduction in relaxation peak height are typical of materials exhibiting thermally activated NTCR (negative temperature coefficient of resistance) behaviour, as was noted in the real impedance analysis. As temperature increases, the faster relaxation dynamics signify that the material's dipoles or charge carriers have lower

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resistance to alignment under the applied field, thereby reducing Z'' and shifting the relaxation response to higher frequencies. This is a common phenomenon in semiconducting and dielectric materials where thermal activation facilitates charge carrier movement and reduces the time constant associated with relaxation processes.⁵⁰

In practical applications, these relaxation characteristics are beneficial for materials used in high-temperature environments, particularly where minimal energy loss and efficient highfrequency response are desired. The imaginary impedance behaviour observed in Fig. 7(b) suggests that this material could be useful in applications such as high-temperature capacitors, dielectric resonators, or thermistors that need stable, low-loss performance over a broad temperature range. The reduction in energy dissipation and the rapid relaxation dynamics at high temperatures make the material suitable for frequency-dependent devices where low Z'' is critical to minimizing dielectric losses. Overall, the imaginary impedance trends across the temperature range offer valuable insights into the dielectric relaxation and thermal activation processes within the material, emphasizing its potential for high-performance applications in temperature- and frequencysensitive electronic components.

To analyze the impact of grains (bulk), grain boundaries and electrodes on the specimen's electrical properties, Nyquist plots (Z' vs. Z'') were generated at different temperatures, as depicted in Fig. 7(c) and (d). Complex impedance measurements for the ceramic compound were recorded over a frequency range of 100 Hz to 1 MHz. To correlate electrical characteristics with the sample's microstructure, an equivalent circuit model incorporating capacitors (C) and resistors (R) was employed. The experimental data were then fitted to theoretical values using ZSIMPWIN software, facilitating a comprehensive comparison between observed and predicted impedance behaviour.

The impact of both bulk grains and grain boundaries is evident up to 300 °C, where semicircular arcs fit well to a series combination of two parallel CR–CQR circuits (Q representing the constant phase element). Also at higher temperatures, grain and grain boundary effects are observed, requiring a series combination of three parallel CQR–CQR circuits for optimal fitting.⁵¹ The depressed semicircular arcs, with centers positioned below the real *Z*/axis, indicate deviations from Debyetype behaviour. Additionally, the decreasing diameter of these semicircles with rising temperature indicates lower resistance values, highlighting the semiconducting nature of the sample.⁵⁰

3.8 Modulus study

An analysis of modulus M(*) was conducted using general equations over a frequency range of 100 Hz to 1 MHz and a temperature range spanning 200 °C to 400 °C.

$$M(^{\star}) = M' + jM'' = j\omega C_0 Z^{\star}$$

$$\tag{4}$$

$$M' = -\omega C_0 Z'' \& M'' = \omega C_0 Z'$$
⁽⁵⁾

3.8.1 Real modulus M'. In Fig. 8(a), which presents the real part of the modulus (M') as a function of frequency across the



Fig. 8 (a) Frequency-dependent variation of M' at different temperatures. (b) Frequency-dependent variation of M'' at different temperatures.

temperature range of 200 °C to 400 °C, we observe a characteristic behaviour often seen in dielectric materials. At lower frequencies, M' values remain low for all temperatures, indicating that the restoring force opposing the mobility of charge carriers is minimal in this range. This low value suggests that at low frequencies, the charge carriers have sufficient time to respond to the oscillating field, allowing them to follow the field without significant hindrance, resulting in minimal modulus.

As frequency increases, however, M' begins to rise gradually for each temperature, eventually reaching a point of nearsaturation at higher frequencies. This trend indicates that, at elevated frequencies, the charge carriers are no longer able to follow the rapidly oscillating field due to limited relaxation time, leading to increased stiffness within the dielectric medium. The saturation at higher frequencies suggests that the material's response becomes independent of frequency in this range, where the modulus reaches a maximum value, representing the intrinsic property of the material.⁵²

The temperature-dependent shift in M' is also evident, with higher temperatures generally showing a more pronounced rise

in modulus as frequency increases. This behaviour aligns with the idea of thermally activated conduction, where increased thermal energy enhances the mobility of charge carriers. However, at high frequencies, the inability of the carriers to follow the field due to rapid oscillations leads to an eventual convergence in M', with only slight variations among different temperatures.

The observed trend, where M' increases from low to high frequencies before stabilizing at a plateau, underscores the dielectric relaxation characteristics of the material. The lower M' at low frequencies and the saturation of the modulus at higher frequencies indicate a shift from conductive to capacitive behaviour, offering valuable insights into the material's relaxation dynamics and its applicability in frequency-dependent dielectric applications. Such modulus behaviour typically signifies localized relaxation processes, wherein charge carriers experience restricted motion due to the material's microstructure or potential barriers limiting their free displacement.⁵³

3.8.2 Imaginary modulus (M'**)**. In Fig. 8(b), the imaginary modulus (M'') is plotted as a function of frequency across a temperature range from 200 °C to 400 °C. This plot reveals important insights into the relaxation dynamics and dielectric behaviour of the material at various thermal states. At the lower end of the temperature spectrum, specifically around 200 °C, M'' exhibits a prominent relaxation peak at a relatively low frequency. This peak at low frequencies signifies that the charge carriers or dipoles within the material have sufficient time to respond to the applied field, resulting in a noticeable energy dissipation or loss in response to the oscillating field. This characteristic peak is indicative of a dielectric relaxation process where the material's dipoles align with the field but cannot do so instantaneously due to structural or intrinsic resistance.

As the temperature increases, the relaxation peak shifts progressively toward higher frequencies. This shift is a common feature in dielectric materials and suggests a temperature-dependent decrease in the relaxation time. Physically, as thermal energy rises, the mobility of charge carriers increases, allowing them to reorient or respond more quickly to the alternating electric field. Thus, at higher temperatures, the dipoles or charge carriers need less time to relax, resulting in the relaxation peak moving to higher frequencies. This temperature-induced shift underscores the thermally activated nature of the relaxation processes within the material and reflects the material's susceptibility to temperature variations.⁵⁴

Notably, while the peak position shifts with temperature, the peak height of *M*" only increases slightly as temperature rises. This relatively modest change in peak height with temperature suggests that the material's loss characteristics-specifically the amount of energy dissipated per cycle are only weakly influenced by the thermal activation at these temperatures. The slight increase in peak height can be attributed to an increase in the number of thermally activated carriers or dipoles that contribute to the relaxation process. However, the limited height variation implies that, despite the higher thermal energy at elevated temperatures, there is a certain level of structural or intrinsic resistance within the material that constrains further energy dissipation. This consistent but slight increase in peak

height also implies that the material maintains a relatively stable loss characteristic across the temperature range, a property that could be beneficial for applications where predictable and stable dielectric loss over a range of operating temperatures is desired. Additionally, the persistence of the relaxation peak across temperatures highlights the inherent dielectric relaxation mechanism of the material, suggesting that it retains its dielectric response characteristics even as thermal conditions change⁵⁵.

3.9 AC conductivity

The electrical conductivity of the samples was measured using a two-terminal method, wherein the pellet sample was clamped between two copper jaws in a heated environment. The AC conductivity σ_{ac} of the synthesized perovskite material was assessed through frequency-dependent response analysis, employing the equation:

$$\sigma_{\rm ac} = \varepsilon_0 \varepsilon_{\rm r} \omega \tan \delta \tag{6}$$

Fig. 9(a) depicts how $\sigma_{\rm ac}$ varies with frequency at temperatures spanning from 200 °C to 400 °C. It is evident from the figure that at low frequencies, $\sigma_{\rm ac}$ remains almost constant, after which it begins to increase at higher frequencies before eventually leveling off. This pattern suggests the presence of space charges and cationic disorder between A and B lattice sites in the material.⁵⁶ As the temperature increases, thermally activated carriers drive a rise in $\sigma_{\rm ac}$ values, which eventually converge at higher temperatures. This temperature-dependent conductivity behaviour indicates the presence of hopping activity in the material. The observed trend confirms the sample's semiconducting nature and its negative temperature coefficient of resistance.

To further analyze the conductivity spectrum, Jonscher's power law was utilised⁵⁷

$$\sigma_{\rm ac} = \sigma_{\rm dc} + A\omega^n \tag{7}$$

It shows a strong agreement with the experimental data. According to Jonscher's model, the frequency-dependent nature of conductivity is attributed to the relaxation dynamics of mobile charges.⁵⁸ The high slope of σ_{ac} at higher frequencies, as observed in Fig. 9(a), indicates a dominant charge-hopping mechanism in the conduction process. This hopping behaviour is likely facilitated by the presence of varying valencies of Ti and Fe ions at the B-site in the perovskite structure. Parameters derived from fitting Jonscher's power law such as σ_{dc} , *n*, and *A* are presented in Table 3, offering a quantitative insight into the conduction properties of the sample. Fig. 9(b) illustrates the temperature-dependent behaviour of parameters A and n. At 200 °C, the parameter A reaches its maximum value, signalling high polarizability; however, as the temperature continues to rise, A gradually decreases. Conversely, n exhibits an opposite trend, reaching its minimum value, which suggests minimal interaction between charge carriers and surrounding sites at that temperature.⁵⁹

Fig. 9(c) displays the relationship between $\ln \sigma_{dc}$ with 1000/ *T*, where an increase in σ_{dc} with temperature confirms NTCR behaviour of the perovskite sample. The activation energy (*E*_a)



Fig. 9 (a) Variation of ac conductivity with frequency at selected temperatures fitted with Jonscher's power law. (b) Variation of A and n with temperature. (c) Variation of dc conductivity with inverse of temperature.

was derived by applying a linear fit to the data using the $Arrhenius relation:^{60}$

$$\sigma_{\rm dc} = \sigma_0 \exp\left(\frac{-E_{\rm a}}{k_{\rm B}T}\right) \tag{8}$$

where $E_{\rm a}$ denotes the activation energy, and $k_{\rm B}$ is the Boltzmann constant. From the slope of the $\ln \sigma_{\rm dc} vs. 1000/T$ plot, the activation energy is calculated to be 0.5634 eV.

3.10 IV Characteristics

Fig. 10(a) displays the relationship between leakage current and bias potential at room temperature, highlighting a marked nonlinearity in the *I–V* curve that signifies non-ohmic behaviour, supporting the sample's semiconducting characteristics. The material's NTCR properties make it suitable for developing a thermistor sensor by analyzing its resistance changes with temperature. Fig. 10(b) illustrates the variation in resistance over the temperature range of 150–450 °C, while Fig. 10(c) shows the dependence of lnR on the inverse of temperature (1/*T*). For a thermistor to operate effectively, its resistance should exhibit a linear correlation with the inverse of absolute temperature on a logarithmic scale-an outcome that aligns well with our experimental results.^{61,62}

To thoroughly evaluate thermistor performance, it is essential to examine key parameters such as the thermistor constant (β) and the sensitivity factor. In the temperature range of 150–450 °C, we utilized the following equations to calculate the thermistor constant (β) and the temperature coefficient of resistance (TCR).

$$TCR = \frac{(R - R_0)}{[R_0(T - T_0)]}$$
(9)

$$\ln R = \ln R_0 + \beta \left(\frac{1}{T} - \frac{1}{T_0}\right) \tag{10}$$

In this context, R_0 and R represent the sample's resistance at temperatures T_0 and T, respectively. For each temperature set, the thermistor constant (β) and TCR values were calculated, with Fig. 10(d) illustrating the relationship between absolute temperature and β . Fig. 10(d) shows that the thermistor constant (β) increases with temperature, aligning with the material's negative temperature coefficient (NTC) properties and confirming its suitability as an NTC thermistor. The highest thermistor coefficient, 4778.61, was recorded at 450 °C, further emphasizing the material's excellent potential for high-performance NTC thermistor applications.^{61,63} The variation of TCR with absolute temperature is depicted in Fig. 10(e). As shown in Fig. 10(e), the non-linear TCR temperature graph perfectly illustrates the significance for thermosensor applications. Using the equation

Table 3 The parameters *A*, *n*, and σ_{dc} at different temperature

Temperature (K)	Α	n	$\sigma_{ m dc}$
473	$3.96957 imes 10^{-9}$	0.87084	$6.85245 imes 10^{-6}$
498	$2.04181 imes 10^{-9}$	0.76757	$9.86917 imes 10^{-6}$
523	$2.34184 imes 10^{-9}$	0.76516	$1.66636 imes 10^{-5}$
548	$3.65381 imes 10^{-9}$	0.74506	$3.31358 imes 10^{-5}$
573	$6.25016 imes 10^{-9}$	0.71807	$5.48469 imes 10^{-5}$
598	$6.96885 imes 10^{-9}$	0.71968	$1.09675 imes 10^{-4}$
623	$6.67878 imes 10^{-9}$	0.73023	$1.80988 imes 10^{-4}$
648	$4.46652 imes 10^{-9}$	0.75885	$2.94978 imes 10^{-4}$
673	4.49731×10^{-9}	0.76126	$3.85584 imes 10^{-4}$



Fig. 10 (a) I-V characteristic of the investigated sample at the room temperature. (b) Variation of *R* with temperature. (c) Variation of $\ln R$ with the inverse of temperature. (d) Temperature-dependent behaviour of thermistor coefficient. (e) Change in temperature coefficient of resistance (TCR) with temperature.

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Temperature	Thermistor		Sensitivity
(°C)	constant (β)	TCR	factor (α)
150	81.65248	-6.22×10^{-4}	$-4.56 imes10^{-4}$
175	128.3211	-8.95×10^{-4}	-6.39×10^{-4}
200	222.54926	-0.00138	-9.95×10^{-4}
225	663.05591	-0.00295	-0.00267
250	863.00418	-0.00317	-0.00316
275	1299.66832	-0.00345	-0.00433
300	1837.30505	-0.00345	-0.0056
325	2547.54791	-0.00329	-0.00712
350	3730.82224	-0.00307	-0.00961
375	4621.27992	-0.00286	-0.01101
400	4731.59309	-0.00267	-0.01045
425	4766.29983	-0.0025	-0.00978
450	4778.61466	-0.00235	-0.00914

Table 5 Presents the thermistor coefficient (β) for some perovskites at different concentrations and temperatures

Sample name	Thermistor constant	Ref.
(Ni _{0.5} Sm _{0.5} FeO ₃) _{0.5} (BaTiO ₃) _{0.5}	3549.43	36
Bi _{0.5} Nd _{0.5} FeO ₃	8417.9	64
Bi _{0.4} Nd _{0.6} FeO ₃	12563.2	65
Bi _{0.3} Nd _{0.7} FeO ₃	10326.5	65
Bi _{0.2} Nd _{0.8} FeO ₃	9414.91	65
Bi _{0.5} Gd _{0.5} FeO ₃	10785	64
Bi _{0.5} La _{0.5} FeO ₃	8145.31	64
$100BaTiO_3 + 10BaBiO_3$	4517	66
$100BaTiO_3 + 10BaBiO_3 + 0.10La_2O_3$	4118	66
$100BaTiO_3 + 10BaBiO_3 + 0.20La_2O_3$	3957	66
$BaTi_{0.85}Ni_{0.1}Co0.05O_{3-\delta}$	3590	67
$BaTi_{0.82}Ni_{0.1}Co0.08O_{3-\delta}$	3796	67
$BaTi_{0.80}Ni_{0.1}Co_{0.10}O_{3-\delta}$	3354	67
$100BaTiO_3 + 20SrBiO_{2.5}$	4124	68
$100BaTiO_3 + 30SrBiO_{2.5}$	4030	68
$100BaTiO_3 + 40SrBiO_{2.5}$	3762	68
$100BaTiO_3 + 50SrBiO_{2.5}$	3654	68
$(Y_{0.5} Ni_{0.5}FeO_3)_{0.5}(BaTiO_3)_{0.5}$ (present sample)	4778.61	

 $\alpha = -\frac{\beta}{T^2}$, we calculated the temperature sensitivity factor (α) across the specified temperature range. Table 4 displays the calculated thermistor constant (β), sensitivity factor (α), and TCR values. Thermistor constant (β) for some of the perovskites at different concentrations and temperatures are shown in Table 5.^{36,64-68} Notably, higher β values and lower TCR values enhance the effectiveness of NTC thermistor applications, underscoring the sample's suitability for these uses.

3.11 Magnetic study

To investigate the magnetic properties of the prepared sample at room temperature, we examine the variation of magnetization (magnetic moment per unit mass) with the applied field, as shown in Fig. 11. In YFeO₃ (YFO), the Dzyaloshinskii–Moriya antisymmetric exchange mechanism causes a slight canting of the Fe³⁺ ion magnetic moments, resulting in weak ferromagnetism¹⁸. The sample exhibits hysteresis, with a residual magnetization of 1.185 emu g⁻¹ and a coercive field of 196.4 Oe, while the saturation

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magnetization reaches approximately 3.654 emu g^{-1} . The presence of magnetic hysteresis, along with non-zero values of coercivity and remanence, confirms the sample's ferromagnetic behaviour.

This sample's ferromagnetic response exceeds previously reported values: Nguyen *et al.*⁶⁹ observe an M_r of 0.019 emu g⁻¹ and an H_C of 53.36 Oe in YFO, while Femina *et al.*⁷⁰ report M_r values of 0.77 emu g⁻¹ and H_C of 1.1 kOe for (SmFeO₃)_{0.5}(Ba-TiO₃)_{0.5}. The enhanced ferromagnetism in the current sample arises from several factors. First, the incorporation of Ti at the Bsite disrupts the Fe–O–Fe network, establishing a new Fe–O–Ti– O–Fe path. Second, the presence of heavier ions like Y and Ba at the A-site causes structural deformation and tilts the FeO₆ octahedron, altering the Fe–O–Fe bond angles.⁷⁰ These improved magnetic properties make the sample a promising candidate for memory device applications.

4. Conclusion

In conclusion, the perovskite sample (Y_{0.5}Ni_{0.5}FeO₃)_{0.5}(Ba- TiO_3)_{0.5} was successfully synthesized using the solid-state reaction method. XRD analysis confirmed its multiphase crystalline structure, while dielectric studies revealed a high dielectric constant (~338 at 100 Hz, room temperature) and NTCR behaviour, indicating its suitability for thermistor applications. Impedance spectroscopy demonstrated strong temperature and frequency-dependent relaxation, with high impedance in the megaohm range at lower temperatures and enhanced energy dissipation due to interfacial polarization. AC conductivity analysis suggested space charge and cationic disorder-driven charge transport. The highest recorded thermistor coefficient (β = 4778.61 at 450 °C) further establishes its potential for temperature-sensing applications. Additionally, room-temperature magnetic measurements confirmed its ferromagnetic nature, with a saturation magnetization of 3.654 emu g^{-1} and coercive field of 196.4 Oe, making it a viable candidate for memory and sensor applications.

For future advancements, the synthesized perovskite material can be incorporated into polymer composite films to explore its flexibility and processability in device fabrication. Furthermore, UV-visible spectroscopy studies can be conducted to determine the optical band gap, which could provide insights into its potential for photocatalytic applications, including environmental remediation and solar-driven energy conversion. These additional investigations would expand the multifunctional utility of $(Y_{0.5}Ni_{0.5}FeO_3)_{0.5}(BaTiO_3)_{0.5}$ beyond dielectric and magnetic applications, paving the way for its integration into next-generation electronic and energy-harvesting devices.

Data availability

Data will be available on request.

Conflicts of interest

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper. We declare that the manuscript is new and has not been submitted anywhere for publication. In addition to the above, we have no conflicts of interest with anybody.

References

- 1 Y. Shen, J. Sun and L. Li, *et al.*, The enhanced magnetodielectric interaction of (1 - x)BaTiO₃-xCoFe₂O₄ multiferroic composites, *J. Mater. Chem. C*, 2014, 2(14), 2545–2551, DOI: 10.1039/C4TC00008K.
- 2 N. Adhlakha, K. L. Yadav and R. Singh, BiFeO₃-CoFe₂O₄-PbTiO₃ composites: structural, multiferroic, and optical characteristics, *J. Mater. Sci.*, 2015, **50**(5), 2073–2084, DOI: **10.1007/s10853-014-8769-z.**
- 3 P. Chang, L. He and H. Wang, Low loss magneto-dielectric composite ceramics Ba₃Co₂Fe₂₄O₄₁/SrTiO₃for high-frequency applications, *J. Am. Ceram. Soc.*, 2015, **98**(4), 1137–1141, DOI: **10.1111/jace.13404**.
- 4 R. Ma, Y. Wang, B. Cui, Y. Wang and Y. Wang, Fabrication of submicron BaTiO₃@ YFeO₃ particles and fine-grained composite magnetodielectric ceramics with a core-shell structure by means of a co-precipitation method, *J. Mater. Sci.: Mater. Electron.*, 2017, **28**, 10986–10991.
- 5 M. N. Shah, N. H. Patel, D. D. Shah and P. K. Mehta Structural and electrical properties of BaTiO₃:YFeO₃ composites at room temperature. B: AIP Conference Proceedings. TOM 2265. AIP Publishing; 2020.
- 6 H. Yang, Y. Yang, Y. Lin and M. Liu, Preparation and electromagnetic properties of *in situ* Ba_{0.8}Sr_{0.2}TiO₃/YFeO₃ composites, *Ceram. Int.*, 2013, **39**(6), 7235–7239, DOI: **10.1016/j.ceramint.2013.01.055**.
- 7 S. Madolappa, B. Ponraj, R. Bhimireddi and K. B. R. Varma, Enhanced magnetic and dielectric properties of Ti-doped YFeO₃ ceramics, *J. Am. Ceram. Soc.*, 2017, **100**(6), 2641–2650.

- 8 M. Wang, T. Wang, S. H. Song, M. Ravi, R. C. Liu and S. S. Ji, Effect of calcination temperature on structural, magnetic and optical properties of multiferroic YFeO₃ nanopowders synthesized by a low temperature solid-state reaction, *Ceram. Int.*, 2017, 43(13), 10270–10276.
- 9 M. Wang, T. Wang, S. Song and M. Tan, Structure-controllable synthesis of multiferroic YFeO₃ nanopowders and their optical and magnetic properties, *Materials*, 2017, **10**(6), 626.
- 10 H. Song and G. Jiang, Effects of Nd, Er doping on the structure and magnetic properties of YFeO₃, *J. Supercond. Novel Magn.*, 2018, **31**, 2511–2517.
- 11 Y. Zhang, J. Yang, J. Xu, Q. Gao and Z. Hong, Controllable synthesis of hexagonal and orthorhombic YFeO₃ and their visible-light photocatalytic activities, *Mater. Lett.*, 2012, **81**, 1–4.
- 12 R. L. Zhang, C. L. Chen, K. X. Jin, L. W. Niu, H. Xing and B. c Luo, Dielectric behavior of hexagonal and orthorhombic YFeO₃ prepared by modified sol-gel method, *J. Electroceram.*, 2014, 32, 187–191.
- 13 A. V. Racu, D. H. Ursu, O. V. Kuliukova, C. Logofatu, A. Leca and M. Miclau, Direct low temperature hydrothermal synthesis of YFeO₃ microcrystals, *Mater. Lett.*, 2015, **140**, 107–110.
- 14 I. Das, S. Chanda, A. Dutta, S. Banerjee and T. P. Sinha, Dielectric relaxation of $Y_{1-x}R_xFeO_3$ (R = Dy, Er, x = 0, 0.5), *J. Alloys Compd.*, 2013, **571**, 56–62.
- 15 C. Zhang, X. Wang, Z. Wang, H. Yan, H. Li and L. Li, Dielectric relaxation, electric modulus and ac conductivity of Mn-doped YFeO₃, *Ceram. Int.*, 2016, 42(16), 19461–19465.
- 16 K. T. Jacob, G. Rajitha and N. Dasgupta Electrical conductivity of Ca-doped YFeO₃. Published online 2012.
- 17 M. Asif, M. Junaid, M. A. Khan, R. T. Rasool and M. J. Akhter, Structural, morphological, dielectric and ferroelectric properties of Nd substituted YFeO₃ ceramics synthesized *via* sol gel auto-combustion route, *Phys. B*, 2023, 667, 415144, DOI: 10.1016/j.physb.2023.415144.
- 18 X. Yuan, Y. Sun and M. Xu, Effect of Gd substitution on the structure and magnetic properties of YFeO₃ ceramics, *J. Solid State Chem.*, 2012, **196**, 362–366.
- 19 A. M. Bolarín-Miró, F. Sánchez-De Jesús, C. A. Cortes-Escobedo, R. Valenzuela and S. Ammar, Structure and magnetic properties of GdxY_{1-x}FeO₃ obtained by mechanosynthesis, *J. Alloys Compd.*, 2014, **586**, S90–S94.
- 20 M. Cheng, G. Jiang and W. Yang, *et al.*, Study of $Y_{1-x}Er_xFeO_3$ ($0 \le x \le 1$) powder synthesized by sol-gel method and their magnetic properties, *J. Magn. Magn. Mater.*, 2016, 417, 87–91.
- 21 B. Deka, S. Ravi, A. Perumal and D. Pamu, Effect of Mn doping on magnetic and dielectric properties of YFeO₃, *Ceram. Int.*, 2017, 43(1), 1323–1334.
- 22 O. Rosales-González, F. Sánchez-De Jesús, C. A. Cortés-Escobedo and A. M. Bolarín-Miró, Crystal structure and multiferroic behavior of perovskite YFeO₃, *Ceram. Int.*, 2018, 44(13), 15298–15303, DOI: 10.1016/j.ceramint.2018.05.175.
- 23 Y. Ma, X. M. Chen and Y. Q. Lin, Relaxorlike dielectric behavior and weak ferromagnetism in YFeO₃ ceramics, *J. Appl. Phys.*, 2008, 103(12), 124111, DOI: 10.1063/1.2947601.

- 24 T. A. Nguyen, V. Pham and D. H. Chau, *et al.*, Effect of Ni substitution on phase transition, crystal structure and magnetic properties of nanostructured YFeO₃ perovskite, *J. Mol. Struct.*, 2020, **1215**, 128293, DOI: **10.1016/j.molstruc.2020.128293**.
- 25 S. Chihaoui, N. Kharrat and M. A. Wederni, *et al.*, Impact of Ni doping on the morphological, electrical and dielectric properties of YMn_{0.4}Fe_{0.6}-*x*Ni_xO₃ (0 ≤ *x* ≤ 0.1) multiferroics, *Phys. B*, 2021, **603**, 412748, DOI: **10.1016/j.physb.2020.412748**.
- 26 B. Bajac, M. Milanovic and Z. Cvejic, *et al.*, Magnetic properties of multilayer BaTiO₃/NiFe₂O₄ thin films prepared by solution deposition technique, *Ceram. Int.*, 2018, 44(13), 15965–15971, DOI: 10.1016/j.ceramint.2018.06.023.
- 27 S. Kumar, F. Ahmed, N. M. Shaalan, N. Arshi, S. Dalela and K. H. Chae, Properties of NiFe₂O₄ Nanoparticles as Electrode Materials for Supercapacitor Applications, *Materials*, 2023, 16, 1–18.
- 28 M. Iliev and M. Abrashev, Raman spectroscopy of orthorhombic perovskitelike and, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1998, 57(5), 2872–2877, DOI: 10.1103/PhysRevB.57.2872.
- 29 S. Raut, P. D. Babu, R. K. Sharma, R. Pattanayak and S. Panigrahi, Grain boundary-dominated electrical conduction and anomalous optical-phonon behaviour near the Néel temperature in YFeO₃ ceramics, *J. Appl. Phys.*, 2018, 123(17), 174101, DOI: 10.1063/1.5012003.
- 30 Z. Ž. Lazarević, Č. Jovalekić and M. Gilić, *et al.*, Yttrium orthoferrite powder obtained by the mechanochemical synthesis, *Sci. Sintering*, 2017, **49**(3), 277–284.
- 31 T. M. Naidu and P. V. L. Narayana, Synthesis and Characterization of Fe–TiO₂ and NiFe₂O₄ Nanoparticles and Its, *J. Nanosci. Nanotechnol.*, 2019, 4–8, DOI: 10.30799/jnst.247.19050407.
- 32 M. Singh, B. C. Yadav, A. Ranjan, M. Kaur and S. K. Gupta, Synthesis and characterization of perovskite barium titanate thin film and its application as LPG sensor, *Sens. Actuators, B*, 2017, **241**, 1170–1178, DOI: **10.1016/j.snb.2016.10.018**.
- 33 A. R. Vázquez-Olmos, M. E. Sánchez-Vergara, A. L. Fernández-Osorio, A. Hernández-García, R. Y. Sato-Berrú and J. R. Alvarez-Bada, Mechanochemical Synthesis of YFeO₃ Nanoparticles: Optical and Electrical Properties of Thin Films, *J. Clust. Sci.*, 2018, 29(2), 225–233, DOI: 10.1007/s10876-017-1330-x.
- 34 Y. K. Anu, Optical and dielectric properties of $Bi_2Ti_2O_7/Bi_4Ti_3O_{12}$ nanocomposite, *Mater. Today: Proc.*, 2020, **28**, 153–157, DOI: **10.1016/j.matpr.2020.01.467**.
- 35 I. G. Jhala, A. Maru and L. Hathiya, *et al.*, Structural, magnetic and electrical properties of gadolinium doped cobalt ferrite nanoparticles: Role of Gd doping level, *Nano-Struct. Nano-Objects*, 2024, **40**, 101327, DOI: **10.1016/j.nanoso.2024.101327**.
- 36 H. Chouhan, S. Prasad and S. Parthasarathy, *et al.*, Unveiling the potential of a novel inorganic perovskite for NTC thermistor and energy-storage applications, *Inorg. Chem. Commun.*, 2024, **170**(P1), 113127, DOI: **10.1016/j.inoche.2024.113127**.
- 37 R. Tang, C. Jiang and W. Qian, *et al.*, Dielectric relaxation, resonance and scaling behaviors in Sr₃Co₂Fe₂₄O₄₁ hexaferrite, *Sci. Rep.*, 2015, 5(1), 13645.
- 38 C. G. Koops, On the dispersion of resistivity and dielectric constant of some semiconductors at audiofrequencies, *Phys. Rev.*, 1951, 83(1), 121.

- 39 I. Ali, M. U. Islam, M. S. Awan and M. Ahmad, Effects of heat-treatment temperature on the microstructure, electrical and dielectric properties of M-type hexaferrites, *J. Electron. Mater.*, 2014, 43, 512–521.
- 40 R. Chakravarty, U. Das, R. K. Parida and B. N. Parida, Multifunctional behavior of solid-state derived Ca-doped BaFe_{0.5}Nb_{0.5}O₃ complex perovskite system, *J. Alloys Compd.*, 2023, 968, 171761, DOI: 10.1016/j.jallcom.2023.171761.
- 41 P. Mallick, S. K. Satpathy and B. Behera, Study of Structural, Dielectric, Electrical, and Magnetic Properties of Samarium-Doped Double Perovskite Material for Thermistor Applications, *Braz. J. Phys.*, 2022, 52(6), 187, DOI: 10.1007/s13538-022-01190-9.
- 42 R. K. Parida, S. Bhattacharjee, B. Mohanty, N. C. Nayak and B. N. Parida, Dielectric and optical spectroscopy of new polycrystalline ceramic for device applications, *J. Mater. Sci.: Mater. Electron.*, 2021, 32(10), 13568–13580, DOI: 10.1007/ s10854-021-05932-4.
- 43 B. Mohanty, S. Bhattacharjee, S. N. Sarangi, N. C. Nayak, R. K. Parida and B. N. Parida, Dielectric, electrical and magnetic characteristics of BST modified BLFO lead free ceramic, *J. Alloys Compd.*, 2021, 863, 158060, DOI: 10.1016/ j.jallcom.2020.158060.
- 44 P. R. Das, S. Behera, R. Padhee, P. Nayak and R. N. P. Choudhary, Dielectric and electrical properties of Na₂Pb₂La₂W₂Ti₄Ta₄O₃₀ electroceramics, *J. Adv. Ceram.*, 2012, (1), 232–240.
- 45 G. N. Bhargavi, A. Khare, T. Badapanda, M. S. Anwar and N. Brahme, Electrical characterizations of BaZr_{0.05}Ti_{0.95}O₃ perovskite ceramic by impedance spectroscopy, electric modulus and conductivity, *J. Mater. Sci.: Mater. Electron.*, 2017, 28, 16956–16964.
- 46 S. Sahoo, P. K. Mahapatra, R. N. P. Choudhary and M. L. Nandagoswamy, Dielectric and impedance spectroscopy of (Ba,Sm)(Ti,Fe)O₃ system in the low-medium frequency range, *J. Mater. Sci.: Mater. Electron.*, 2015, 26(9), 6572–6584, DOI: 10.1007/s10854-015-3255-1.
- 47 S. Sahoo, L. Sahoo, N. C. Nayak, B. N. Parida and R. K. Parida, Investigation of the structural, dielectric, magnetic properties and NTC-thermistor response of CaBiFeMnO₆ double perovskites, *Mater Adv.*, 2024, 5(13), 5442–5457, DOI: 10.1039/d4ma00175c.
- 48 B. Tiwari and R. N. P. Choudhary, Effect of Mn-substitution on structural and dielectric properties of Pb(Zr_{0.65-x}Mn_x-Ti_{0.35})O₃ ceramics, *Solid State Sci.*, 2009, **11**(1), 219–223.
- 49 R. Mumtaz, W. H. Shah and Y. Iqbal, *et al.*, Electrical transport and dielectric relaxation mechanism in Zn_{0.5}Cd_{0.5}Fe₂O₄ spinel ferrite: A temperature- and frequency-dependent complex impedance study, *Heliyon*, 2024, **10**(14), e34155, DOI: **10.1016/j.heliyon.2024.e34155**.
- 50 S. Bhattacharjee, B. Mohanty, R. K. Parida and B. N. Parida, Multifunctional characterization of Ca-modified new double perovskite for energy harvesting devices, *Phys. B*, 2022, 624, 413373, DOI: 10.1016/j.physb.2021.413373.
- 51 A. R. Tanna, S. S. Srinivasan and H. H. Joshi, Enhancement in magnetoelectric properties of lead-free multiferroic

composite through high-energy mechanical milling, *J. Mater. Sci.: Mater. Electron.*, 2020, 9306–9320, DOI: 10.1007/s10854-020-03470-z.

- 52 K. Parida, S. K. Dehury and R. N. P. Choudhary, Electrical, optical and magneto-electric characteristics of BiBaFeCeO₆ electronic system, *Mater. Sci. Eng. B*, 2017, **225**, 173–181.
- 53 S. Pattanayak, B. N. Parida, P. R. Das and R. N. P. Choudhary, Impedance spectroscopy of Gd-doped BiFeO₃ multiferroics, *Appl. Phys. A: Mater. Sci. Process.*, 2013, **112**, 387–395.
- 54 M. A. L. Nobre and S. J. Langfred, *Phys. Chem. Solids*, 1999, 62, 20–24.
- 55 F. Brahma, B. Mohanty, S. Bhattacharjee, R. L. Hota, R. K. Parida and B. N. Parida, Multiferroic behaviour in 'Bi' doped solid solution SmFeO₃–BaTiO₃ perovskite system, *Ceram. Int.*, 2022, 48(13), 18286–18293, DOI: 10.1016/ j.ceramint.2022.03.087.
- 56 N. K. Karan, D. K. Pradhan, R. Thomas, B. Natesan and R. S. Katiyar, Solid polymer electrolytes based on polyethylene oxide and lithium trifluoro-methane sulfonate (PEO-LiCF₃SO₃): Ionic conductivity and dielectric relaxation, *Solid State Ionics*, 2008, **179**(19–20), 689–696.
- 57 A. K. Jonscher, The 'universal'dielectric response, *Nature*, 1977, **267**(5613), 673–679.
- 58 F. I. H. Rhouma, A. Dhahri, J. Dhahri and M. A. Valente, Dielectric, modulus and impedance analysis of lead-free ceramics $Ba_{0.8}La_{0.133}$ Ti_{1-x}Sn_xO₃ (x = 0.15 and 0.2), *Appl. Phys. A: Mater. Sci. Process.*, 2012, **108**, 593–600.
- 59 D. K. Pradhan, B. Behera and P. R. Das, Studies of dielectric and electrical properties of a new type of complex tungsten bronze electroceramics, *J. Mater. Sci.: Mater. Electron.*, 2012, 23, 779–785.
- 60 J. R. Macdonald, Note on the parameterization of the constantphase admittance element, *Solid State Ionics*, 1984, **13**(2), 147–149.
- 61 S. Sahoo, S. Mishra, L. Sahoo, B. N. Parida, L. Biswal and R. K. Parida, Dielectric, electric, and magnetic response of modified bismuth ferrite-based double perovskites for NTCthermistor application, *Ceram. Int.*, 2024, **50**(11), 20011–20025.
- 62 D. Panda, S. S. Hota and R. N. P. Choudhary, Development of a novel triple perovskite barium bismuth molybdate material for thermistor-based applications, *Mater. Sci. Eng., B*, 2023, **296**, 116616, DOI: **10.1016/j.mseb.2023.116616**.
- 63 D. Panda, S. S. Hota and R. N. P. Choudhary, Development of a novel triple perovskite barium bismuth molybdate material for thermistor-based applications, *Mater. Sci. Eng. B*, 2023, **296**, 116616.
- 64 A. K. Sahu, P. Mallick, S. K. Satpathy and B. Behera, Effect on structural, electrical and temperature sensing behavior of neodymium doped bismuth ferrite, *Adv. Mater. Lett.*, 2021, 12(7), 1–7.
- 65 P. Mallick, A. K. Sahu, S. K. Biswal, S. K. Satpathy and B. Behera, Investigation on Structural, Dielectric, Thermistor Parameters and Negative Temperature Coefficient Behaviour of Nd, Gd, and La-Doped Bismuth Ferrite, *Trans. Electr. Electron. Mater*, 2022, 23(5), 522–534, DOI: 10.1007/s42341-021-00379-0.

- 66 O. La, Electrical properties of BaTiO₃-based NTC thermistors doped, *J. Mater. Sci.: Mater. Electron.*, 2006, 909–913, DOI: 10.1007/s10854-006-0043-y.
- 67 J. Chen, H. Zhang, G. Li, J. Wang and Z. Li, Co/Ni Co-doped BaTiO₃ based NTC thermistors with Li₂CO₃ as sintering additive, *J. Chin. Ceram. Soc.*, 2011, **39**, 978–983.
- 68 X. Li, BaTiO₃ and SrBiO_{2.5} two phase system NTC thermistors, *J. Mater. Sci.: Mater. Electron.*, 2008, 3, 271–274, DOI: 10.1007/s10854-007-9281-x.
- 69 A. T. Nguyen, H. D. Chau, T. T. L. Nguyen, V. O. Mittova and D. T. Huong, Structural and magnetic properties of $YFe(1 x)Co_xO_3$ (0.1 < x < 0.5) perovskite nanomaterials synthesized by coprecipitation method, *Nanosyst.: Phys., Chem., Math.*, 2018, 3, 424–429, DOI: 10.17586/2220-8054-2018-9-3-424-429.
- 70 F. Brahma, B. Mohanty, S. Bhattacharjee, R. L. Hota, R. K. Parida and N. Parida, Investigation of multifunctional characteristics in SmFeO₃–BaTiO₃ perovskite system for devices, *Mater. Sci. Semicond. Process.*, 2021, 135, 106071, DOI: 10.1016/j.mssp.2021.106071.